

FCC Part15 Subpart B TEST REPORT

For

Multi-Microwave Oven

MODEL NUMBER: EC042AI0-S(GE)

REPORT NUMBER: 4788710010-F01-00

ISSUE DATE: Oct 27,2018

FCC ID No.: VG8XC042AYYGEW

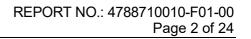
Prepared for

Guangdong Midea Kitchen Appliances Manufacturing Co.,Ltd No.6, Yong An Road, Beijiao, Shunde, Foshan, Guangdong, China 528311

Prepared by

UL-CCIC Company Limited
Electronic Building, Parage Electronic Industrial Park, No. 8 Nanyun Er Road,
Guangzhou Science Park, Guangzhou, 510663 China
Website: www.ul.com

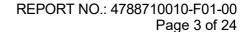
The results reported herein have been performed in accordance with the laboratory's terms of accreditation. This report shall not be reproduced except in full without the written approval of the Laboratory. The results in this report apply to the test sample(s) mentioned above at the time of the testing period only and are not to be used to indicate applicability to other similar products. This report does not imply that the product(s) has met the criteria for certification.





Revision History

Rev.	Issue Date	Revisions	Revised By
	10/27/2018	Initial Issue	





Summary of Test Results							
Standard Test Item Limit Result Rem							
	Conducted Disturbance	Class B	PASS	1			
FCC Part15, Subpart B ANSI C63.4-2014	Radiated Disturbance below 1 GHz	Class B	PASS	1			
ANOI 000.4-2014	Radiated Disturbance above 1 GHz	Class B	PASS	NOTE (1)			

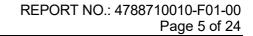
Note:

- (1) If the highest frequency of the internal sources of the EUT is less than 108 MHz, the measurement shall only be made up to 1 GHz. If the highest frequency of the internal sources of the EUT is between 108 MHz and 500 MHz, the measurement shall only be made up to 2 GHz. If the highest frequency of the internal sources of the EUT is between 500 MHz and 1 GHz, measurement shall only be made up to 5 GHz. If the highest frequency of the internal sources of the EUT is above 1 GHz, the measurement shall be made up to 5 times the highest frequency or 40 GHz, whichever is less.
- (2) The product is a Multi-function equipment. This report only assesses the digital circuit functions of products, except the ISM part.



CONTENTS

Ι.	ATTES	TATION OF TEST RESULTS	5
2.	. TEST I	METHODOLOGY	6
3.	FACILI	TIES AND ACCREDITATION	6
4.	CALIB	RATION AND UNCERTAINTY	7
	4.1.	Measuring Instrument Calibration	7
	4.2.	Measurement Uncertainty	7
5.	EQUIP	MENT UNDER TEST	8
	5.1.	Description of EUT	8
	5.2.	Test Mode	8
	5.3.	EUT Accessory	8
	5.4.	Block Diagram Showing the Configuration of System Tested	
6.	. MEASI	JRING EQUIPMENT AND SOFTWARE USED	10
7.	EMICC	ION TEST	44
	. EIVIIJJ	IUN E3	11
	7.1. 7.1.1. 7.1.2. 7.1.3. 7.1.4. 7.1.5. 7.1.6.	Conducted Disturbance Measurement. Limits of conducted disturbance voltage Test Procedure. Test Setup Test Environment. Test Mode. Test Results.	11 11 11 12 12 12
	7.1. 7.1.1. 7.1.2. 7.1.3. 7.1.4. 7.1.5.	Conducted Disturbance Measurement. Limits of conducted disturbance voltage Test Procedure. Test Setup. Test Environment. Test Mode.	11 11 12 12 12 13 15 16 16 17 17
8.	7.1. 7.1.1. 7.1.2. 7.1.3. 7.1.4. 7.1.5. 7.1.6. 7.2. 7.2.1. 7.2.2. 7.2.3. 7.2.4. 7.2.5. 7.2.6.	Conducted Disturbance Measurement. Limits of conducted disturbance voltage Test Procedure Test Setup Test Environment. Test Mode. Test Results. Radiated Disturbance Measurement. Limits of radiated disturbance measurement. Test Procedure Test Setup Test Setup Test Environment. Test Mode.	11 11 12 12 12 13 15 16 16 17 17 18





1. ATTESTATION OF TEST RESULTS

Applicant Information Company Name: Guangdong Midea Kitchen Appliances Manufacturing Co.,Ltd No.6, Yong An Road, Beijiao, Shunde, Foshan, Guangdong, China 528311				
Manufacturer Information Company Name: Address:	Same as the Applicant Same as the Applicant			
Factory Information Company Name: Address:	Same as the Applicar			
EUT Information EUT Name: Model: Brand: Sample Status: Sample ID: Sample Received Date: Date of Tested:	Multi-Microwave Oven EC042AI0-S(GE) C A F É Normal #1 Oct 22, 2018 Oct 22,2018~Oct 27,2018			
	APPLICABLE ST	TANDARDS		
STANDARI	DS	TEST RESULTS		
FCC Part15, Su ANSI C63.4-2		PASS		
Prepared By:		Checked By:		
Een Shan		Linda Ni		
Yam Shan Project Engineer		Linda Ni Senior Project Engineer		



2. TEST METHODOLOGY

All tests were performed in accordance with the standard FCC Part15 Subpart B and ANSI C63.4-2014.

3. FACILITIES AND ACCREDITATION

Accreditation Certificate	A2LA (Certificate No.: 4338.01) Shenzhen STS Test Services Co., Ltd. has been assessed and proved to be in compliance with A2LA. CNAS (Registration No.: L7649) Shenzhen STS Test Services Co., Ltd. has been assessed and proved to be in compliance with CNAS. FCC (FCC Designation No.: 625569) Shenzhen STS Test Services Co., Ltd. has been recognized to perform compliance testing on equipment subject to the Commission's Delcaration of Conformity (DoC) and Certification rules
------------------------------	--

Note 1: All tests measurement facilities use to collect the measurement data are located at 1/F., Building B, Zhuoke Science Park, No.190, Chongqing Road, Fuyong Street, Bao'an District, Shenzhen, Guangdong, China



4. CALIBRATION AND UNCERTAINTY

4.1. Measuring Instrument Calibration

The measuring equipment utilized to perform the tests documented in this report has been calibrated in accordance with the manufacturer's recommendations, and is traceable to recognized national standards.

4.2. Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the apparatus:

Test Item	Measurement Frequency Range	К	U(dB)
Conducted disturbance at mains terminals ports	0.15MHz ~ 30MHz	2	2.67 dB
Radiated disturbance Test	Below 1GHz	2	3.73 dB
Radiated disturbance Test	Above 1GHz	2	3.31 dB

Note: This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.



5. EQUIPMENT UNDER TEST

5.1. Description of EUT

EUT Name	Multi-Microwave Oven
EUT Description	A microwave oven with heating function
Model EC042AI0-S(GE)	
Series Models	/
Model difference	EC042A##-S(GE) (remark: ## denote cosmetic differences, # could be from 0 to 9 or from A to Z)
Power Supply:	AC 120V 60Hz 1600W
Power Cord:	3 pins, AC input cable

5.2. Test Mode

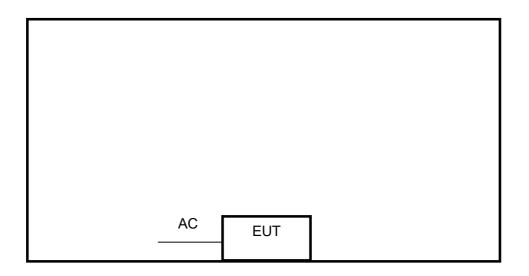
Test Mode	Description	
Mode 1	Working with Heating mode.	
Mode 2	Working with Heat Fan mode.	

5.3. EUT Accessory

Item	Accessory	Brand Name	Model Name	Description
1	1	/	1	1



5.4. Block Diagram Showing the Configuration of System Tested



The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Item	Equipment	Mfr/Brand	Model/Type No.	Specification	Series No.
	1		1	1	

Item	Type of cable	Shielded Type	Ferrite Core	Length



6. MEASURING EQUIPMENT AND SOFTWARE USED

Disturbance Voltage					
Equipment	Manufacturer	Model No.	Serial No.	Cal Until	
Test Receiver	R&S	ESCI	101427	2019.10.14	
LISN	R&S	ENV216	101242	2019.10.14	
Conduction Cable	EM	C01	N/A	2019.10.17	
Temperature & Humidity	Mieo	HH660	N/A	2019.10.14	

Radiated Emission							
Equipment	Manufacturer	Model No.	Serial No.	Cal Until			
EMI Test Receiver	R&S	ESCI	102086	12 Oct, 2019			
Bilog Antenna	TESEQ	CBL6111D	34678	29 Oct, 2019			
Horn Antenna	SCHWARZBECK	BBHA 9120D	1343	26 Oct, 2019			
Spectrum Analyzer	Agilent	E4407B	MY50140340	07 Mar, 2019			
Pre-Amplifier(1G- 26.5G)	Agilent	8449B	60538	14 Oct, 2019			
Spectrum Analyzer	Agilent	N9020A	MY49100060	07 Mar, 2019			
Pre- Amplifier(0.1M- 3GHz)	EM	EM330		27 Oct, 2019			



7. EMISSION TEST

7.1. Conducted Disturbance Measurement

7.1.1. Limits of conducted disturbance voltage

FREQUENCY	□Class A (dBμV)		⊠Class B (dBµV)	
(MHz)	Quasi-peak	Average	Quasi-peak	Average
0.15 -0.5	79.00	66.00	66 - 56 *	56 - 46*
0.50 -5.0	73.00	60.00	56.00	46.00
5.0 -30.0	73.00	60.00	60.00	50.00

Note:

- (1) The tighter limit applies at the band edges.
- (2) The limit of " * " marked band means the limitation decreases linearly with the logarithm of the frequency in the range.
- (3) The test result calculated as following: Measurement Value = Reading Level + Correct Factor Correct Factor = Insertion Loss + Cable Loss + Attenuator Factor Margin Level = Measurement Value - Limit Value

The following table is the setting of the receiver

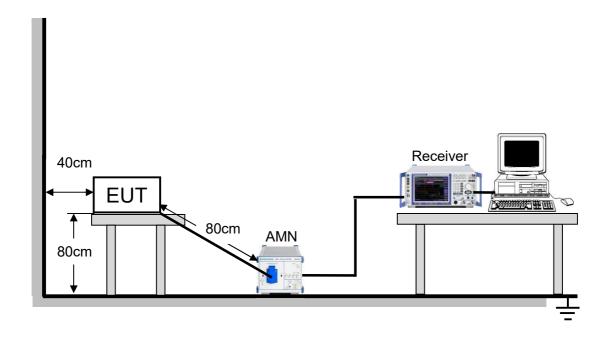
Receiver Parameters	Setting
Attenuation	10 dB
Start Frequency	0.15 MHz
Stop Frequency	30 MHz
IF Bandwidth	9 kHz

7.1.2. Test Procedure

- a. The EUT was placed 0.8 meters from the horizontal ground plane with EUT being connected to the power mains through a line impedance stabilization network (LISN). All other support equipments powered from additional LISN(s). The LISN provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.
- c. I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.
- d. LISN at least 80 cm from nearest part of EUT chassis.
- e. For the actual test configuration, please refer to the related Item:EUT Test Photos.



7.1.3. Test Setup



For the actual test configuration, please refer to Appendix I: Photographs of the Test Configuration.

7.1.4. Test Environment

Temperature:	26.1°C
Humidity:	55%
ATM pressure:	101kPa

7.1.5. Test Mode

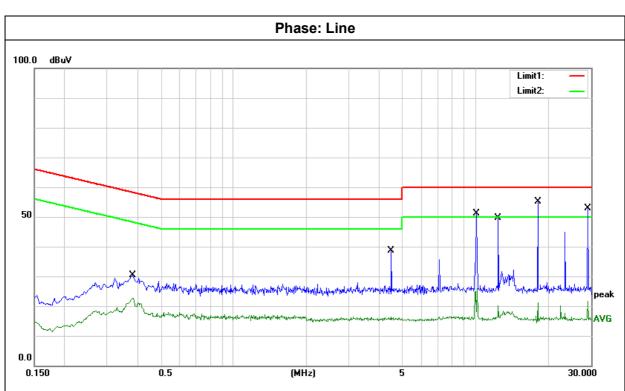
Test Mode:	Mode 2	
------------	--------	--

Note: According to pre-test results, the final test mode is each independent function's worst case and only shown in the report.



7.1.6. Test Results

Model:	EC042AI0-S(GE)
Test Voltage:	AC 120V/60Hz

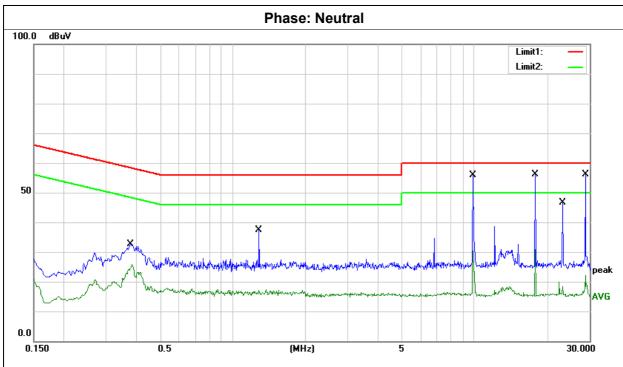


No.	Frequency	Reading	Correct	Result	Limit	Margin	Remark
	(MHz)	(dBuV)	Factor(dB)	(dBuV)	(dBuV)	(dB)	
1	0.3820	9.87	20.57	30.44	58.24	-27.80	QP
2	0.3820	2.14	20.56	22.70	48.15	-25.45	AVG
3	4.4820	18.47	20.05	38.52	56.00	-17.48	QP
4	4.4820	-3.74	20.05	16.31	46.00	-29.69	AVG
5	10.1100	31.33	19.85	51.18	60.00	-8.82	QP
6	10.1100	6.03	19.85	25.88	50.00	-24.12	AVG
7	12.4020	29.80	19.84	49.64	60.00	-10.36	QP
8	12.4020	0.38	19.84	20.22	50.00	-29.78	AVG
9	18.1300	35.18	19.90	55.08	60.00	-4.92	QP
10	18.1300	1.14	19.90	21.04	50.00	-28.96	AVG
11	29.1300	33.34	19.60	52.94	60.00	-7.06	QP
12	29.1300	2.02	19.60	21.62	50.00	-28.38	AVG

Remark:

Result = Reading +Correct Margin = Result - Limit





No.	Frequency	Reading	Correct	Result	Limit	Margin	Remark
	(MHz)	(dBuV)	Factor(dB)	(dBuV)	(dBuV)	(dB)	
1	0.3780	12.09	20.58	32.67	58.32	-25.65	QP
2	0.3780	5.28	20.58	25.86	48.32	-22.46	AVG
3	1.2860	17.27	20.16	37.43	56.00	-18.57	QP
4	1.2860	-2.87	20.16	17.29	46.00	-28.71	AVG
5	9.8620	36.10	19.86	55.96	60.00	-4.04	QP
6	9.8620	10.45	19.86	30.31	50.00	-19.69	AVG
7	17.8780	36.16	19.90	56.06	60.00	-3.94	QP
8	17.8780	10.91	19.90	30.81	50.00	-19.19	AVG
9	23.2340	27.08	19.65	46.73	60.00	-13.27	QP
10	23.2340	0.33	19.65	19.98	50.00	-30.02	AVG
11	28.8820	36.54	19.60	56.14	60.00	-3.86	QP
12	28.8820	2.59	19.60	22.19	50.00	-27.81	AVG

Remark: Result = Reading +Correct Margin = Result – Limit



7.2. Radiated Disturbance Measurement

7.2.1. Limits of radiated disturbance measurement

Below 1 GHz

Measurement Method and Applied Limits:

ANSI C63.4:

7 11 1 0 1 0 0 0 1 1 1			
Frequency	□CI	⊠Class B	
(MHz)	Field strength	Field strength	Field strength
,	(uV/m) (at 10m)	(dBuV/m) (at 3m)	(dBuV/m) (at 3m)
30 - 88	90	49.5	40
88 - 216	150	53.9	43.5
216 - 960	210	56.9	46
Above 960	300	60	54

Above 1 GHz

Measurement Method and Applied Limits:

ANSI C63.4:

Fraguanay		□Class A				⊠Class B	
Frequency	(dBuV/m) (at 3m)	(dBuV/m)) (at 10m)	(dBuV/m) (at 3m)	
(MHz)	Peak	Average	Peak	Average	Peak	Average	
Above 1000	80	60	69.5	49.5	74	54	

Frequency Range of Radiated Disturbance Measurement

requeries runge of rudiated Bistarbarios incasarement						
Highest frequency generated or Upper frequency of measurement used in the device or on which the device operates or tunes (MHz)	Range (MHz)					
Below 1.705	30					
1.705 - 108	1000					
108 - 500	2000					
500 - 1000	5000					
Above 1000	5 th harmonic of the highest frequency or 40 GHz, whichever is lower					

NOTE:

- (1) The limit for radiated test was performed according to FCC Part 15, Subpart B;
- (2) The tighter limit applies at the band edges;
- (3) Emission level (dBuV/m) = 20log Emission level (uV/m), 3m Emission level = 10m Emission level + 20log(10m/3m);
- (4) The test result calculated as following: Measurement Value = Reading Level + Correct Factor, Correct Factor = Antenna Factor + Cable Loss - Amplifier Gain(if use), Margin Level = Measurement Value - Limit Value.

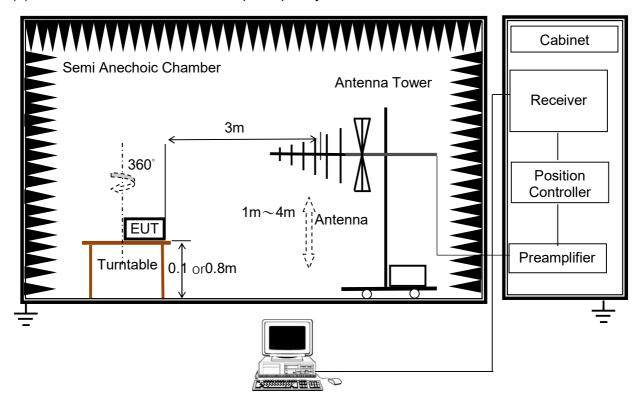


7.2.2. Test Procedure

- a. The measuring distance of at 3m shall be used for measurements at frequency up to 1GHz.
- b. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter chamber. The table was rotated 360 degrees to determine the position of the highest radiation.
- c. The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For the actual test configuration, please refer to the related Item:EUT Test Photos.

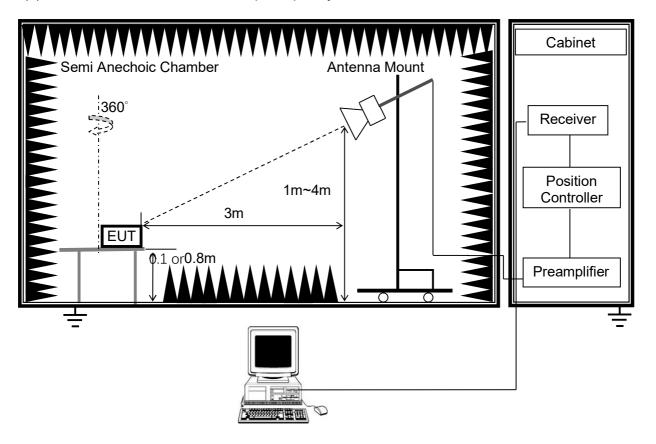
7.2.3. Test Setup

(a) Radiated Disturbance Test Set-Up Frequency 30MHz - 1GHz





(b) Radiated Disturbance Test Set-Up Frequency above 1GHz



For the actual test configuration, please refer to Appendix I: Photographs of the Test Configuration.

7.2.4. Test Environment

Radiated Disturbance - below 1 GHz		Radiated Disturbance - above 1 GHz	
Temperature:	25.2°C	Temperature:	25.2°C
Humidity:	60%	Humidity:	60%
ATM pressure:	101.1kPa	ATM pressure:	100.1kPa

7.2.5. Test Mode

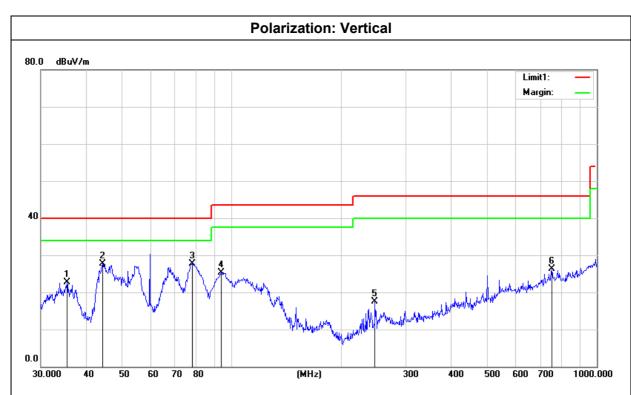
Radiated Dist	urbance - below 1 GHz	Radiated Disturbance - above 1 GHz		
Test Mode:	Mode 2	Test Mode:	Mode 2	

Note: According to pre-test results, the final test mode is each independent function's worst case and only shown in the report.



7.2.6. Test Results - below 1GHz

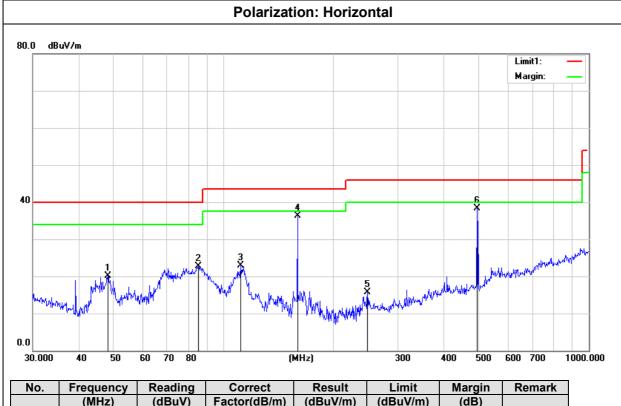
Model:	EC042AI0-S(GE)
Test Voltage:	AC 120V/60Hz



No.	Frequency	Reading	Correct	Result	Limit	Margin	Remark
	(MHz)	(dBuV)	Factor(dB/m)	(dBuV/m)	(dBuV/m)	(dB)	
1	35.3750	36.72	-13.94	22.78	40.00	-17.22	QP
2	44.2752	46.30	-18.53	27.77	40.00	-12.23	QP
3	77.8654	50.66	-23.00	27.66	40.00	-12.34	QP
4	93.4402	45.24	-19.85	25.39	43.50	-18.11	QP
5	246.8150	34.38	-16.79	17.59	46.00	-28.41	QP
6	752.7432	29.97	-3.57	26.40	46.00	-19.60	QP

Note: 1. Result Level = Read Level + Antenna Factor + Cable loss - PRM Factor





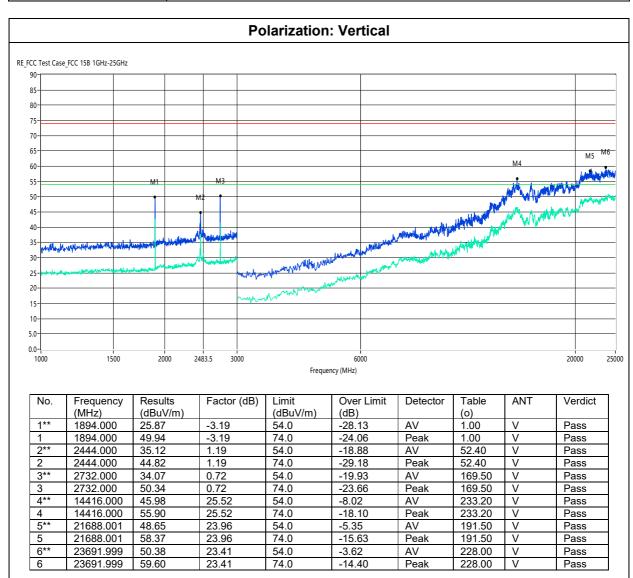
No.	Frequency	Reading	Correct	Result	Limit	Margin	Remark
	(MHz)	(dBuV)	Factor(dB/m)	(dBuV/m)	(dBuV/m)	(dB)	
1	48.1626	40.57	-20.53	20.04	40.00	-19.96	QP
2	85.2980	43.98	-21.37	22.61	40.00	-17.39	QP
3	111.3468	41.13	-18.25	22.88	43.50	-20.62	QP
4	159.2251	54.81	-18.46	36.35	43.50	-7.15	QP
5	247.6820	32.41	-16.66	15.75	46.00	-30.25	QP
6	494.1984	47.41	-9.05	38.36	46.00	-7.64	QP

Note: 1. Result Level = Read Level + Antenna Factor + Cable loss - PRM Factor



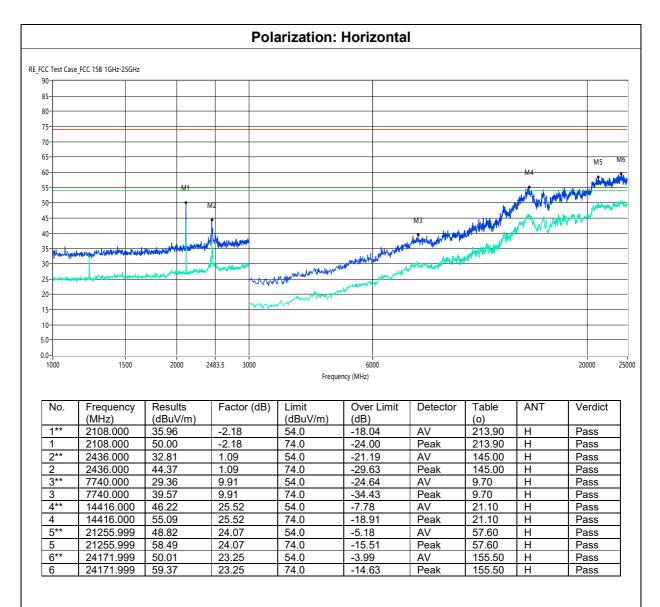
7.2.7. Test Results - Above 1GHz

Model:	EC042AI0-S(GE)
Test Voltage:	AC 120V/60Hz



Note: 1. Result Level = Read Level + Antenna Factor + Cable loss - PRM Factor





Note: 1. Result Level = Read Level + Antenna Factor + Cable loss - PRM Factor



8. Appendix I: Photographs of EMC Test Configuration

Conducted Disturbance

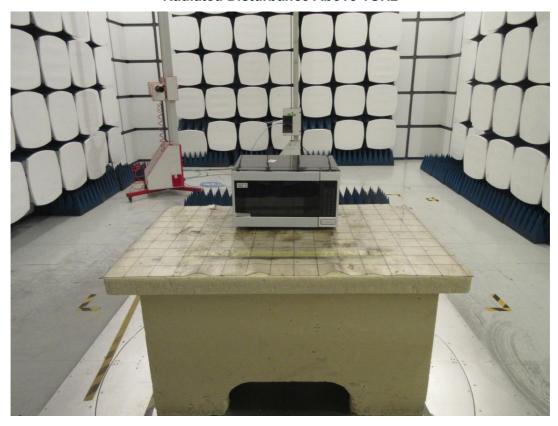




Radiated Disturbance below 1GHz



Radiated Disturbance Above 1GHz





REPORT NO.: 4788710010-F01-00

Page 24 of 24

9. Appendix II: Photographs of the EUT

- -	END OF REPORT	
Refer to the Appe	endix report 4788710010-A1&4	4788710010-A2